Search Notes

Application/Control No.  Applicant(s)/Patent under Reexamination	
10/724,736	WOO ET AL.
Examiner	Art Unit
Rita R. Patel	1746

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Class	Subclass	Date	Examiner
68	13A	9/17/2006	RRP
68	18R	9/17/2006	RRP
68	12.01	9/17/2006	RRP
68	12.14	9/17/2006	RRP
68	12.16	9/17/2006	RRP
68	12.17	9/17/2006	RRP
68	12.21	9/17/2006	RRP

INTERFERENCE SEARCHED					
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